

MTP2955V

P-Channel Enhancement Mode Field Effect Transistor

General Description

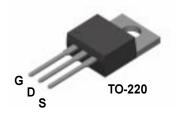
This P-Channel MOSFET has been designed specifically for low voltage, high speed switching applications i.e. power supplies and power motor controls.

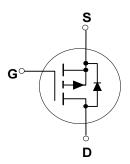
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\scriptscriptstyle \mathrm{DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies).

Features

- -12 A, -60 V. $R_{DS(ON)} = 0.230 \Omega @ V_{GS} = -10 V$
- Critical DC electrical parameters specified at elevated temperature.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{DSS}	Drain-Source Voltage	-60	V
V _{GSS}	Gate-Source Voltage	<u>+</u> 20	V
I _D	Drain Current - Continuous	-12	А
	- Pulsed	-42	
P _D	Total Power Dissipation @ T _C = 25°C	60	W
	Derate above 25∘C	0.40	W/∘C
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-65 to +175	∘C
Therma	l Characteristics		
R _e Jc	Thermal Resistance, Junction-to- Case	2.5	∘C/W
$R_{\theta^{\mathrm{JA}}}$	Thermal Resistance, Junction-to- Ambient (Note 1)	62.5	∘C/W

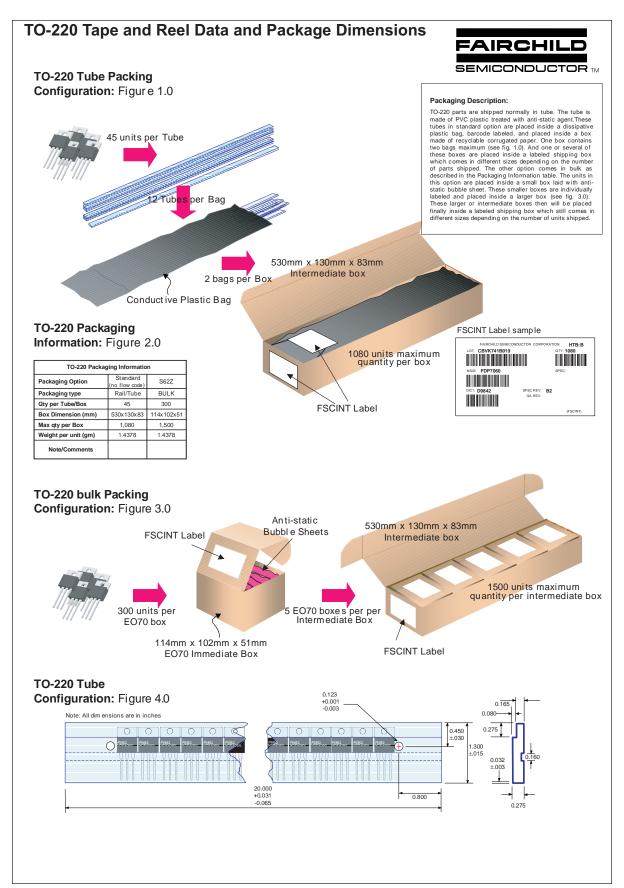
Package Outlines and Ordering Information

Device Marking	Device	Package Information	Quantity
MTP2955V	MTP2955V	Rails/Tubes	45 units
MTP2955V	MT P2955V	Rails/Tubes	

^{*} Die and manufacturing source subject to change without prior notification.

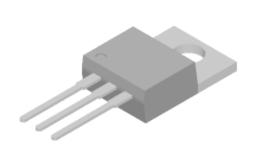
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
DRAIN-S	OURCE AVALANCHE RATI	NGS (Note 2)				
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = -25 \text{ V}, I_{D} = -12 \text{ A}$			216	mJ
I _{AR}	Maximum Drain-Source Avalanche	e Current			-12	Α
Off Char	a otoriotico					
BV _{DSS}	octeristics Drain-Source Breakdown Voltage	$V_{GS} = 0 \ V_{_1} I_{D} = -250 \ \mu A$	-60			V
<u>∆</u> BVɒss ∧TJ	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C		-63		mV/∘C
DSS	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V			-10	μА
DSS	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V, T _J = 150∘C			-100	μΑ
GSSF	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-2	-3	-4	V
ΔVGS(th)	Gate Threshold Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C		5		mV/∘C
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V,I _D = -6 A,			0.230	Ω
V _{DS(on)}	Drain Source On-Voltage	I _D = -12 A, V _{GS} = -10 V			-2.9	V
g fs	Forward Transconductance	V _{DS} = -10 V, I _D = -6 A	3.0			S
Dynamic	Characteristics					
C _{iss}	Characteristics Input Capacitance	V _{DS} = -25 V, V _{GS} = 0 V,			700	pF
Coss	Output Capacitance	f = 1.0 MHz			280	pF
C _{rss}	Reverse Transfer Capacitance				100	pF
	·					
	g Characteristics (Note 2)	L		I		
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -30 \text{ V, } V_{D} = -12 \text{ A,}$ $V_{GS} = -10 \text{ V, } R_{GEN} = 9.1 \Omega.$			30	ns
t _r	Turn-On Rise Time	VGS = -10 V, TGEN = 3.1 <u>C2</u>			100	ns
t _{d(off)}	Turn-Off Delay Time				50	ns
t _f	Turn-Off Fall Time				80	ns
Q _g	Total Gate Charge	$V_{DS} = -48 V_1$			30	nC
Q_{gs}	Gate-Source Charge	$ I_D = -12 \text{ A}, V_{GS} = -10 \text{ V}$		3		nC
Q _{gd}	Gate-Drain Charge			5	ļ	nC
<u>Drain-So</u>	urce Diode Characteristics	and Maximum Ratings				
s	Maximum Continuous Drain-Source	ce Diode Forward Current (Note 2)			-12	Α
SM	Maximum Pulsed Drain-Source Di	ode Forward Current (Note 2)			-42	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = -12 A (Note 2)			-3.0	V

^{1.} $R_{0,JA}$ is the sum of the juntion-to-case and case-to-ambient thermal resistance. 2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

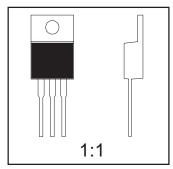


TO-220 Tape and Reel Data and Package Dimensions, continued

TO-220 (FS PKG Code 37)

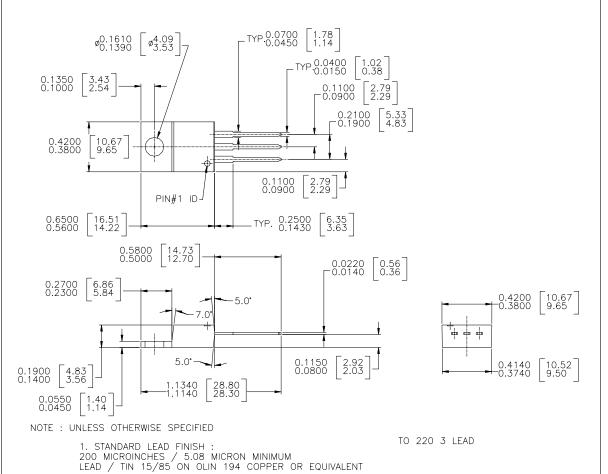


2. DIMENSION BASED ON JEDEC STANDARD TO-220 VARIATION AB, ISSUE J, DATED 3/24/87



Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 1.4378



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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition			
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
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